

<b>Notice of References Cited</b>	Application/Control No. 10/734,221	Applicant(s)/Patent Under Reexamination NAGASAWA ET AL.	
	Examiner Stephen J. Stein	Art Unit 1775	Page 1 of 1

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	B	US-6,416,578	07-2002	Nakano et al.	117/94
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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